|    | Туре | L # | Hits | Search Text                       | DBs   |
|----|------|-----|------|-----------------------------------|---|
| 1  | IS&R | L1  | 56   | (257/922).CCLS.                   | USPAT   |
| 2  | BRS  | L2  | 1942 | organic adj semiconductor         | USPAT   |
| 3  | BRS  | L3  | 1    | 2 and tamper                      | USPAT   |
| 4  | BRS  | L4  | 7542 | organic adj semiconductor         | US-PGPUB; USPAT;<br>USOCR; FPRS; EPO;<br>JPO; DERWENT;<br>IBM_TDB |
| 5  | BRS  | L5  | 9    | 4 and tamper                      | US-PGPUB; USPAT;<br>USOCR; FPRS; EPO;<br>JPO; DERWENT;<br>IBM_TDB |
| 6  | BRS  | L6  | 634  | 4 and protection                  | US-PGPUB; USPAT;<br>USOCR; FPRS; EPO;<br>JPO; DERWENT;<br>IBM_TDB |
| 7  | BRS  | L7  | 2    | 4 and (protection adj<br>portion) | US-PGPUB; USPAT;<br>USOCR; FPRS; EPO;<br>JPO; DERWENT;<br>IBM_TDB |
| 8  | BRS  | L8  | 215  | 4 and crack                       | US-PGPUB; USPAT;<br>USOCR; FPRS; EPO;<br>JPO; DERWENT;<br>IBM_TDB |
| 9  | BRS  | L9  | 71   | 8 and memory                      | US-PGPUB; USPAT;<br>USOCR; FPRS; EPO;<br>JPO; DERWENT;<br>IBM_TDB |
| 10 | BRS  | L10 | 5    | 4 and (seal with strip\$4)        | US-PGPUB; USPAT;<br>USOCR; FPRS; EPO;<br>JPO; DERWENT;<br>IBM_TDB |

|    | Туре | L#  | Hits | Search Text                        | DBs   |
|----|------|-----|------|------------------------------------|---|
| 11 | BRS  | L11 | lh   | 4 and (protection with activat\$4) | US-PGPUB; USPAT;<br>USOCR; FPRS; EPO;<br>JPO; DERWENT;<br>IBM_TDB |